# Length-dependent resistance model for a single-wall Carbon nanotube

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The non-linear length-dependent resistance, R (l) observed in single-wall Carbon nanotubes (SNTs) is explained through the recently proposed ionization energy (E<sub>I</sub>) based Ferm i-D irac statistics (iFDS). The length here corresponds to the Carbon atoms number (N) along the SNT. It is also shown that R<sub>y</sub> (l<sub>y</sub>) < R<sub>x</sub> (l<sub>x</sub>) is associated with E<sub>I</sub> < E<sub>X</sub>, which can be attributed to different conducting properties in their respective y and x directions, or due to chirality.

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### I. INTRODUCTION

Enorm ous amount of research have been poured since the discovery of Carbon (C) nanotubes (CNTs) by Iijim a [1] in 1991 and consequently, CNTs have been successfully exploited to produce cathode ray tubes [2] and nano-electronic devices [3]. Understandably, CNTs are believed to pave the pioneering pace for the nanotechnology boom . Basically, C can be categorized into graphite, diam ond and Fullerenes based on their bonding nature that gives rise to dierent electronic and structural properties. Unexpectedly, C in all these three structures with slight manipulations have exposed superconductivity [4, 5, 6]. CNTs' electronic properties are equivalent to rolled-graphite [7, 8, 9, 10] which also reveal superconductivity in the absence of doping [11, 12, 13] and concentration-dependent non-linear optical properties. The real part of third-order non-linear susceptibility, Re  $^{(3)}$  was found to be in the order of 10  $^{11}$  esu for multi-wall CNTs by Elim's group [14]. This value is roughly 100 larger than that of SNTs, which is due to SNT's lower C-atom concentration. The superconducting properties of Boron-doped diam onds [15] based on resonating-valence-bond mechanism was put forward by Baskaran [4, 5] whereas, the superconducting Fullerenes and its non-linear optical properties have been discussed by Cohen et al. [16] and Elim et al. [17] respectively.

Here, the ionization energy based Ferm i-D irac statistics (iFDS) is employed to derive the length-dependent resistance model, R (l). The derivation of iFDS and its applications in a wide variety of strongly correlated electronic matter is given in the Refs. [18, 19, 20, 21]. This model is shown to be viable in addressing the recent R (l) observation reported by de Pablo et al. [22], Andriotis et al. [23] and Purewalet al. [24] in CNTs. The length-dependent resistance is an intrinsic property basically because the contact resistance is independent of CNT's length [22]. As a consequence, the only questionable result is the magnitude of the resistance, not its

length-dependent trend. However, other measurements nam ely, the tem perature (T)-dependent electrical or heat conductance are strongly in uenced by the contact resistance due to its own T-dependence and its large magnitude, usually in the order of the CNTs resistance, which in turn waver the intrinsic experimental R (T) results. It is interesting to note that the resistance of a SNT is non-linearly proportional to the tube's length in both m etallic and sem iconducting SNTs [24, 26, 27] at any given T. However, the calculations carried out by Zhang et al. [26] and Uryu et al. [28, 29] for metallic CNTs indicate that the resistance is inversely proportional to the length as a result of resonant tunelling at interface. In this work, we do not consider heterostructures with resonant tunneling, but rather, on intrinsic metallic and sem iconducting SN T s. The resistance model derived here are also suitable in other strongly correlated nanotubes that allow direct-current resistance and/or polarization m easurem ents, or if the C atom s in CNT s are doped substitutionally with dierent atoms.

# II. THE LENGTH -DEPENDENT RESISTANCE MODEL

We start with the many-body Hamiltonian [30, 31],

$$\frac{2}{2m} r^{2} r^{2} = (E + V (r))'; \qquad (1)$$

of which,

$$\hat{\mathbf{H}}' = (\mathbf{E}_0)' : \qquad (2)$$

From Eq. (2), one can notice that the in uence of the potential energy on the total energy has been conveniently parameterized as . This energy function, can be characterized in such a way that  $E_0$  is the total energy, E at T=0. Add to that, from Eq. (2), it is obvious that the magnitude of is given by  $=E_{\rm kin}$   $E_0+V$  (r),  $E_{\rm kin}$  denotes the kinetic energy. Physically, in plies the energy needed to overcome the potential energy that exists in a particular system . That is, is the energy needed

to excite a particular electron to a nite distance, r, not necessarily r ! 1 . Literally, this is exactly what we need to know in any condensed matter that actually or reasonably de nes the properties of the ferm ions. H is the usual H am ilton operator, 'denotes the many-body eigenstate and E  $_{0}$  is the total energy at T = 0. The + sign of is for the electron (0 ! +1 ) while the sign is for the hole ( 1 ! 0). In addition, we de ne the ionization energy in a many-atom system , =  $E_{\rm I}^{\rm real}$  is approximately proportional to  $E_{\rm I}$  of an isolated atom or ion. We can prove the validity of Eq. (2) by means of constructive (existence) and/or direct proofs as given in Ref. [31]. However, for an isolated atom , is given by

$$= E_{kin} \quad E_0 + V_{pot} = E_I; \tag{3}$$

The corresponding total energy is

$$E_0 = E_{kin} + V_{pot}$$
$$= E_0 \quad E_T:$$
(4)

On the other hand, for an atom in a many-atom system, we can rewrite Eq. (3) as

$$= E_{kin} E_0 + V_{pot} + V_{m \text{ any body}}$$

$$= E_I + V_{m \text{ any body}}$$

$$= E_T^{real}; (5)$$

Note here that  $V_{\text{pot}}$  is the atom ic Coulomb potential, while the  $V_{\text{m any body}}$  is the many body potential averaged from the periodic potential of the atom ic arrangement. The corresponding total energy from Eq. (5) is given by

$$E_0 = E_{kin} + V_{pot} + V_{m \text{ any body}}$$

$$= E_0 \quad E_I + V_{m \text{ any body}}$$

$$= E_0 \quad E_I^{\text{real}}; \qquad (6)$$

In this case, E  $_{\rm I}^{\rm real}$  is the ionization energy of an atom in a many-atom system (not isolated). The exact values of E  $_{\rm I}$  are known for an isolated atom . As a consequence, we can arrive at Eq. (2) from Eq. (6). Apparently, we cannot use Eq. (2) to isolate the electronic and phonon contributions because we have de ned the as a function of the C oulom b potential ( $V_{\rm pot}$ ), many-body ( $V_{\rm many\ body}$ ) and kinetic (E  $_{\rm kin}$ ) energies. Consequently, the total energy can also be rewritten as (from Eq. (6))

$$E = E_0 \qquad E_{\text{li;j}}^{\text{real}}; \qquad (7)$$

where, j is the sum over the constituent elements in a particular compound. For a C nanotube with only one type of atom, Eq. (7) can be rewritten as

$$E = E_0 \qquad E_{\text{Ii}}; \qquad (8)$$

In Eq. (8), we have de ned here that  $= 1 + \frac{hV (r)i}{E_I}$ , where hV (r)i is the averaged m any-body potential value. A part from that, the total energy equation for a free-electron system is given by

$$E = E_0 \qquad E_{\text{li;j}}$$

$$= E_0 \qquad E_{\text{kin}} \qquad E_0 + V_{\text{pot}} + V_{\text{many body}}$$

$$= E_{\text{kin}} + V_{\text{pot}} + V_{\text{many body}}, \text{ for electrons } ! +$$

$$= E_{\text{kin}} + V_{\text{total}}$$

$$= E_{\text{kin}}, \text{ im plies free electrons:} \qquad (9)$$

In Eq. (9) we have substituted Eq. (5) for  $E_{\tau}^{\text{real}}$  because the concept of ionization energy is irrelevant for freeelectron m etals, which do not require excitations from its parent atom to conduct electricity. As such, the carrier density is independent of tem perature and the scattering rate is the one that determ ines the resistivity with respect to tem perature, im purities, defects, electron-electron and electron-phonon interactions. In sum mary, the total energy from Eq. (2) carries the ngerprint of each C atom in a nanotube and it refers to the di erence in the energy levels of each atom rather than the absolute values of each energy level (eigenvalues) in each atom. Hence, the kinetic energy of each electron from each atom will be captured by the total energy and preserves the atom ic level electronic- ngerprint in the nanotube. Using this newly de ned total energy, we can derive the ionization energy based Ferm i-D irac statistics (iFDS) as given below [18]

$$f_{e} (E_{0}; ) = \frac{1}{e^{[(E_{0}+ )E_{p}^{0}]=k_{B}T} + 1};$$

$$f_{h} (E_{0}; ) = \frac{1}{e^{[E_{p}^{0}(E_{0})]=k_{B}T} + 1};$$
(10)

where,  $E_F^0$  is the Ferm i level at T=0 and  $k_B$  is the Boltzm ann constant. However, substituting the same atom in a nanotube gives rise to the in uence of manybody V (r) and in reality,  $E_I^{\rm real}$  cannot be evaluated from Eq. (5). Nevertheless, the  $E_I^{\rm real}$  of an atom or ion in a nanotube is proportional to the isolated atom and/or ion's  $E_I$  as given in Eq. (8). It is this property that enables one to predict the variation of ferm ionic excitation probability in C nanotubes. Therefore, one can employ the experimental atom is spectra to estimate,  $E_I^{\rm real}/E_I$ . It is emphasized here that  $E_I$  is zero for Boltzmann particles. As such, one should not assume that the above approximation should give the Boltzmann distribution function (BDF) as a classical limit. One can indeed arrive at BDF by rst denying the additional constraint by

substituting  $E_{\rm I}=0$ . Im portantly, Eq. (10) is the Ferm i-D irac statistics derived specifically for strongly correlated matter, where it is not applicable for free-electron system (or Ferm igas) as shown in Eq. (9).

Now, before we move on, let us re-exam in e Eq. (5) that seems to say nothing about i) the atom ic arrangements and ii) how to isolate the phonon from electronic contribution. Firstly, Eq. (5) is perfectly applicable for any atom ic arrangem ents or crystal structures. The reason is that we can incorporate Eqs. (5) and (10) for both nonbulk system , namely  ${\tt SNTs}$  as well as for bulk system , regardless of its speci c crystal structures, since these two equations can be normalized by employing the appropriate density-of-states (DOS). However, for non-bulk system of several atoms, including SNTs, we need to incorporate the atom ic arrangem ent explicitly because the electronic excitation depends on the number of atoms along a certain conducting path (developed here). For bulk system with the number of atoms of the order of 10<sup>23</sup>, the e ect of di erent crystal structures do not arise because the conducting paths are isotropic and the  $E_{\,\mathrm{T}}$ here will and can be dressed accordingly to take this structural e ect into account [18, 19, 20, 21, 30]. For exam ple, pure diam ond and graphite will each have different valence states and electronic polarizabilities (the ability of the valence electrons to excite in a particular direction in the presence of electric eld), in which, these di erences are due to the di erent excitations of the valence electrons. These di erent excitations of the valence electrons are the ones that have been captured by Eq. (10) through Eq. (5). Therefore, in our approach, the true DOS and/or atom ic arrangements of a particular system are unnecessary. The price we pay for this is that we cannot calculate the many-body eigenstates from Eq. (2), but note here that we can indeed prove Eq. (2) m icroscopically for real isolated atom s [31]. In other words, our input param eter is the isolated atom icenergy-level-di erence, or de ned here as the ionization energy (E<sub>I</sub>). The theoretical discussion of how E<sub>I</sub> a ect the polarizability can be found in Ref. [21].

The second issue here is how do we isolate the phonon from the electronic counterpart? Basically, we cannot and there is no reason to, at least for condensed matter that violate free-electron metals and for as long as we do not apply this form alism to evaluate them al conductivity. The next question is, how E  $_{\rm I}$  is related to electron-phonon interaction in the rst place? We will answer this shortly. The 1-dimensional (1D) DOS is given by N  $_{\rm e}$  (E ,1D) = E  $^{1=2}$  (m  $_{\rm e}$ =2)  $^{1=2}$  = ~, using E =  $^{2}$ k  $^{2}$ =2m  $_{\rm e}$  and k denotes the wave vector. The integral to compute carrier density and its solution are given by (aftermaking use of Eq. (10))

$$n = \int_{0}^{\mathbb{Z}} f_{e}(E_{0}; E_{I}) N_{e}(E) dE$$

$$= \frac{k_{B} T m_{e}}{2^{2}} \exp \frac{E_{F}^{0} E_{I}}{k_{B} T} : (11)$$

Based on Eq. (11), suppose that the system is at tem perature T and it has n number of electrons per unit volume. Now, im agine that we reduce the magnitude of  $E_{I}$  (sm all enough that it does not increase n), then the only parameter that can change is the e ective mass of the electron, where m  $_{\rm e}$  / E  $_{\rm I}$ , which in turn implies that the electron-phonon coupling (elph) has been reduced. This same argument with small E $_{\rm I}$  variations can be applied at any reasonable tem peratures. However, for free electron m etals,  $_{\rm elph}$  is de ned as the electron-phonon scattering, where electrons and phonons can be treated as two di erent entities that scatter each other. In our approach, we do not treat the electrons and phonons, even in m etallic SNTs as separate entities. In addition, E $_{\rm I}$  in this case has no relation with electron-phonon scattering. Switching back to the SNT, the charge (g)-gradient along a nanotube's length (1) and the drift velocity (va) of charges can be written as [32]

$$\frac{dq}{dl} = n de; \frac{dl}{d} = v_d:$$
 (12)

As such, one can write the current (i) as [32]

$$i = \frac{dq}{d} = \frac{dq}{dl} \quad \frac{dl}{d} = n \quad dev_d$$
: (13)

Now, the resistance for a single conducting path or length, of a SNT is  ${\bf N}$ 

$$\frac{R}{d} = \frac{V}{i} = \frac{1}{i} \quad E \text{ dr}; \tag{14}$$

d denotes the tube's diam eter and E = electric eld. We also know that m (dv\_d=d ) = eE that eventually gives  $v_d=$  eE =m . Finally, one can arrive at the resistance of a whole nanotube, as given below

$$R (1) = \frac{(d)^{2}E}{i} = d\frac{m}{ne^{2}} = d(E_{I})$$

$$= d\frac{A}{e^{2}} \frac{2m_{e}}{k_{B}} \int_{1}^{1=2} T^{3=2} \exp \frac{E_{I} E_{F}^{0}}{k_{B} T}$$

$$= dA (13062) \exp \frac{E_{I} E_{F}^{0}}{k_{B} T} : (15)$$

We have substituted, m =ne $^2$  e e for (E\_I) and the electron-electron scattering rate, 1/e e = AT $^2$ . The

 $_{\rm elph}$  has been neglected because SNTs are not free-electronm etals, even them etallicones. However, for heat transport,  $_{\rm elph}$  is not negligible. A is the T-independent scattering rate constant. The numerical value is obtained for T = 300 K . The 1D resistivity,  $(E_{\rm I})$  for nanotubes can be written as

$$(E_I) = \frac{A^{\sim}}{e^2} \frac{2 \text{ m}}{k_B} T^{3=2} \exp \frac{E_I E_F^0}{k_B T}$$
: (16)

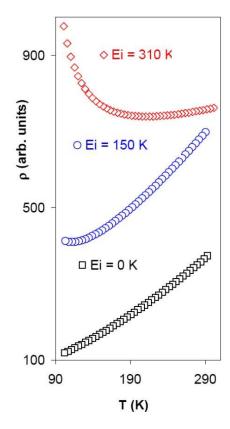


FIG. 1: The intrinsic T-dependence of 1D resistivity is T  $^{3-2}$  for T above E  $_{\rm I}$ . For T below E  $_{\rm I}$ , (E  $_{\rm I}$ ) is proportional to exp (1=T). There are three di erent curves for di erent m agnitudes of E  $_{\rm I}$ .

The calculated curves from Eq. (16) are shown in Fig. 1. Interestingly, one of the curve (E $_{\rm I}$  = 150 K) is comparable with the experimental data in Ref. [24] (see Figure 2b). The calculation of the total average ionization energy (in the respective y and x directions) can be carried out with

$$E_{I}^{\gamma,x} [C^{z+}] = X^{z} X \frac{E_{Ii}^{\gamma,x}}{z} N_{j}; \qquad (17)$$

Unlike ionic bulk systems, CNTs are 1D systems with anisotropic conducting paths, which have covalent bonds. Consequently, the following de nitions and descriptions

are essential. The C in Eq. (17) represents the Carbon atom while z denotes the number of valence electrons that can be excited, which will eventually contributes to the conductance of CNTs in the presence of applied voltage. Apart from N (the number of C atoms along a conducting path), the number of valence electron that are excited for conduction in the y direction is not equal to the x. M eaning, the strength of the resistance or conductance in their respective y and x directions of a SNT originate from the inequality,  $E_{\rm I}^{\rm y}(N) < E_{\rm I}^{\rm x}(N)$ . The subscripts, i=1,2,... z and j adds the C atoms, 1, 2, and so on continuously along its conducting path or length. In the previous work on superconductors and ferroelectrics [18, 19, 20, 21], Eq. (17) was simply written as the average ionization energy of a single ion as given in

$$E_{I} = \frac{X^{z}}{\sum_{i}^{z}} \frac{E_{Ii}}{z}$$
: (18)

The relative magnitude of  $E_{\rm I}$  was then calculated based on the percentage of dopant to predict the variation of (T) and dielectric constant. On the contrary, SNTs with nite length in nanoscale and with only one type of atoms namely, C requires  $E_{\rm I}$  in the form of Eq. (17).

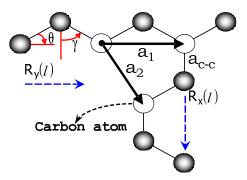


FIG. 2: The arrangement of C atoms in a single-wall C arbon nanotube is shown schematically. The resistance is strongly in uenced by the direction (y;x) in which  $R_{y;x}$  is measured. Such observation is due to the inequality,  $E_{x}^{y}(N) < E_{x}^{x}(N)$ . The dened angles, and can be used to compute the length as given in the Eqs. (19) and (20), respectively.  $a_{c}$  denotes the length of covalent bond between two C atoms.

Figure 2 schem atically shows the arrangement of C atoms in the y and x directions. Taking  $a_{\rm c\ c}$  (0.142 nm ) as the distance between the two C atoms, one can write

$$L_y = L_x = a_{c c} N_j 1$$
: (19)

The  $L_y$  and  $L_x$  are the lengths along the C C atom's bond. Therefore, the experim entally measurable lengths (in real space) can be written as (as a function of L)

$$l_y = L_y \cos() = a_{cc} \cos() N_j = 1;$$
 (20)

$$l_{x} = \frac{1 + 2\cos()}{3}L_{x}$$

$$= \frac{a_{c c}}{3} 1 + 2\cos() \sum_{j=2}^{X} N_{j} 1; \qquad (21)$$

Recall here that the reason 1 in Eqs. (20) and (21) are written as functions of L is to take into account the higher probability of electrons to conduct along the L. The angles, is the chiral angle, while = 90°, which are also de ned in Fig. 2. The subscript, j = 2 indicates the sum starts from the second C atom and so on. The chiral vector,  $C_h$  is given by [25]

$$C_h = na_1 + m a_2;$$

where  $a_1$  and  $a_2$  denote the 2D graphene lattice vectors, while n and m are integers.  $C_h$  can be related to x (=0) and y (=30) with

$$C_h(x) = na_1 + na_2;$$
  
 $C_h(y) = na_1:$ 

Consequently, Eq. (17) in y and x directions can be respectively rewritten as

$$E_{I}^{Y}[C^{z+}] = \frac{X^{z}}{z} \frac{E_{Ii}^{Y}}{z} \frac{1_{y}}{a_{c} c c c c c} + 1 : \qquad (22)$$

$$E_{I}^{x}[C^{z+}] = \frac{X^{z}}{z} \frac{E_{Ii}^{x}}{z} \frac{3l_{x}}{a_{cc} 1 + 2\cos(z)} + 1 : (23)$$

Now, one can actually substitutes either Eq. (22) or Eq. (23) accordingly into Eq. (15) in order to obtain the length-dependent resistance. In addition, we can see that both Eqs. (22) and (23) are also determ ined by the chiral vectors.

## III. ANALYSIS OF R (1)

The R (1) of free-electron m etals with isotropic distribution of atoms and electrons can be simply derived as R (1) =  $\frac{1}{S}$ , S denotes the cross section area [32]. However, CNTs resistance at 300 K, say in the x direction should be written as

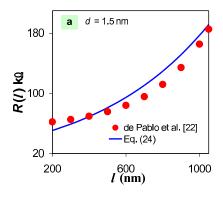
$$R_{x} = d (E_{I})$$

$$= dA (13062)$$

$$\exp \frac{3l_{x}}{a_{cc} 1 + 2\cos()} + 1 E_{I} E_{F}^{0} \frac{1}{k_{B}T}$$

$$dA (13062) \exp \frac{Bl_{x}}{T} : (24)$$

Equation (24) accommodates the unit for  $(E_1^{\gamma,x})$ , which is m  $^1$  (because the unit for 1D n from Eq. (13) is m  $^1$ ). The length, 1 varies exponentially as a result of Eq. (15). Figure 3 a) and b) indicate the in uence of length on resistance via Eq. (24). The in Fig.3 a) and b) represent the experimental data from de Pablo et al. for the nanotube samples with diam eters, d=1.5 nm and 1.7 nm respectively. The solid lines are based on Eq. (24).



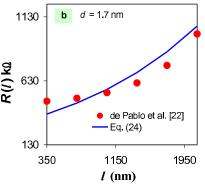


FIG. 3: The length-dependent resistance (R) based on Eq. (24) (solid lines) are plotted to evaluate the experimental data () obtained from R ef. [22].

Importantly, the ttings in Fig. 3 a) and b) clearly demonstrate that Eq. (24) gives a reasonable approximation. With this model at our disposal, one can utilize the tting parameters namely, dA (13062) = 37 k for d = 1.5 nm whereas dA (13062) = 300 k for d = 1.7 nm. Therefore,  $A_{1:5} = 6.01 \cdot 10^8 \, \mathrm{s}^1 \, \mathrm{K}^2$  and  $A_{1:7} = 4.30 \cdot 10^9 \, \mathrm{s}^1 \, \mathrm{K}^2$ . As a result of this, the e-e scattering rate

for 1.5 nm and 1.7 nm nanotubes are respectively given by  $_{ee} = 1.85 10^{-14} sand <math>_{ee} = 2.58 10^{-15}$ Eventually, the mean free path,  $l_e = F_{ee} = (8.1)$  $10^{5}$ )(1.85  $10^{14}$ ) = 15 nm for d = 1.5 nm, and for d = 1.7 nm,  $l_e$  = 2 nm. Here, the Ferm ivelocity,  $_F$  is obtained from Ref. [12]. The other tting parameter, B for d = 1.5 nm and 1.7 nm are found to be 0.47 and 0.18 respectively. Throughout this resistance calculations, e-ph scattering has been neglected in the usual sense, because  $\mathbb{F}DS$  have had the electrons dressed with  $\mathbb{E}_{\mathbb{I}}$ . M eaning, the excitation of electrons and holes varies with dierent types of atom s (in this case C), identically with the traditional m ethods discussed by Barnett et al. [33], Perebeinos et al. [34] and Ando [35]. Contrary to FDS, the latterm ethods utilize the free-electron theory and subsequently the e-ph interaction was determined in order to couple it with those free-electrons so as to describe the excitation of electrons and holes with di erent types of atom s. Consequently, one can notice that Eq. (24) does not ignore e-ph interactions in any way. In fact, the existence of polaronic e ect via  $E_{\rm I}$  has been discussed using iFDS [20]. Parallel to this, Perebeinos et al. [34] have also found strong polaronic e ect in SNTs as inevitable.

The properties of phonons and its in uence in CNTs speci cally and other nanostructures generally have been discussed extensively in the Refs. [36, 37, 38, 39, 40, 41, 42, 43]. Apart from that, Chen et al. [44] pointed out the possibility of superconductivity and ferrom agnetism in SNTs doped by a chain of C atom s. W hereas, Ichida et al. [45] have carried out the necessary analysis on the relaxation dynam ics of photoexcited states in SNTs using fem to second spectroscopy. They found an interesting relationship of which, the e-ph interaction increases with decreasing tube diam eter. Qualitatively, their result explains why for smalld (1.5 nm), the B (0.47) determined earlier is 2.6 larger than the magnitude of B (0.18),

which is for large d (1.7 nm). Recall here that B corresponds to E  $_{\rm I}$ , which is associated to the heavier elective m ass (polaronic elect). In other words, this polaronic effect is due to the interaction between non free-electrons and phonons, which enhances the elective mass of the charge carriers [20]. On the contrary, for the well known e-ph interaction in metals, free-electrons and phonons interact, that eventually gives rise to e-ph scattering. Having said that, we can now compare our predicted values for  $l_{\rm e}$  (2 to 15 nm) with the values obtained by considering the short optical phonon mean-free-path (10 to 20 nm, for low bias-voltage and d = 1.5 to 2 nm) that  $\lim$  its the electrons mean-free-path [3].

#### IV. CONCLUSIONS

In conclusion, the ionization energy based Ferm i-D irac statistics has been employed to derive the length-dependent resistance in a single-wall C arbon nanotube. It has been shown that such dependence is inevitable in a low dimensional and non-free-electron systems at nanoscales by using the the recent experimental ndings. In this paper, it is also highlighted that simple equations derived using iFDS are able to capture the transport properties of single-wall C arbon nanotubes with reasonable accuracy.

# A cknow ledgm ents

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